

**COPY**

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Moshe Finarov

Assignee: Nova Measuring Instruments, Ltd.

Title: APPARATUS FOR OPTICAL INSPECTION OF WAFERS DURING  
POLISHING

Serial No.: Unknown

Filed: March 25, 1998

Examiner: Unknown

Group Art Unit: Unknown

Docket No.: M-3417-1C US

San Jose, California  
March 25, 1998

ASSISTANT COMMISSIONER FOR PATENTS  
BOX PATENT APPLICATION  
Washington, D. C. 20231

**PRELIMINARY AMENDMENT  
AND STATEMENT UNDER 37 C.F.R. § 1.163(d)(2)**

Dear Sir:

Prior to examining this continuing application (which is a continuation of U.S.S.N.  
08/497,382, filed June 29, 1995), kindly amend the continuing application as follows:

IN THE TITLE

On page 1, after the title "APPARATUS FOR OPTICAL INSPECTION OF  
WAFERS DURING POLISHING", delete the names of the inventors "Eran Dvir, Eli  
Haimovich and Benjamin Shulman" as Moshe Finarov is the sole inventor in this application.

IN THE DRAWINGS

Please amend Figures 6-9 as shown in the red-ink mark up of these figures as  
originally filed in the prior application identified above.

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